Search Notes

Application/C	Application/Control No.		Applicant(s)/Patent under Reexamination	
10/764,283		CHAPMAN,	THOMAS R.	
Examiner		Art Unit		
Devin Hanan		3745		

	SEAR	CHED	
Class	Subclass	Date	Examiner
415	206		
416	175,183		
	185, 187		
	186R		
264	328.1	4/20/2005	DH
updated	above	10/5/2005	DH

INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
-			
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
consulted Chris Verdier on class 416 and 415	4/20/2005	DH		
consulted Jill Heitbrink on class 264/328.1	4/13/2005	DH		